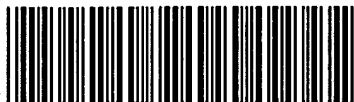


**Search Notes**

Application/Control No.

10/676,591

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

FLETCHER, DEAN H.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	385	5/23/2006	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same	as Above	5/23/2006	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/383,486 (see printouts)	5/23/2006	SHL
235/462.08, 462.14, 462.24, 462.25 (see printouts)	5/23/2006	SHL
PCT cites	5/23/2006	SHL
NPL	5/23/2006	SHL